

<b>Notice of References Cited</b>	Application/Control No. 10/626,693		Applicant(s)/Patent Under Reexamination MEYER, JOHN F.	
	Examiner Madeleine AV Nguyen		Art Unit 2625	Page 1 of 2

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,283,820 A	02-1994	Ishiwatari et al.	379/100.02
*	B	US-5,898,434 A	04-1999	Small et al.	715/810
*	C	US-5,993,216 A	11-1999	Stogner, Robert B.	434/29
*	D	US-6,072,600 A	06-2000	Wertsberger, Shalom	358/479
*	E	US-6,134,105 A	10-2000	Lueker, Mark David	361/683
*	F	US-2001/0000249 A1	04-2001	Oba et al.	455/412
*	G	US-2001/0016819 A1	08-2001	Kolls, H. Brock	705/1
*	H	US-6,618,553 B1	09-2003	Shiohara, Ryuichi	386/117
*	I	US-6,784,925 B1	08-2004	Tomat et al.	348/207.11
*	J	US-6,832,083 B1	12-2004	Oba et al.	455/412.1
*	K	US-6,972,792 B2	12-2005	Dow et al.	348/231.6
*	L	US-7,034,966 B1	04-2006	Kubo, Masahiro	358/474
*	M	US-2006/0072016 A1	04-2006	Shiohara, Ryuichi	348/207.2

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>	Application/Control No. 10/626,693	Applicant(s)/Patent Under Reexamination MEYER, JOHN F.	
	Examiner Madeleine AV Nguyen	Art Unit 2625	Page 2 of 2

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,262,301 A	04-1981	Erllichman, Irving	386/31
*	B	US-6,282,362 B1	08-2001	Murphy et al.	386/46
*	C	US-6,366,698 B1	04-2002	Yamakita, Tooru	382/187
*	D	US-6,927,870 B1	08-2005	Shimazawa et al.	358/1.15
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.